

Search Notes

Application/Control No.

10/660,033

Examiner

Alan S. Chen

Applicant(s)/Patent under
Reexamination

BEUKEMA ET AL.

Art Unit

2182

SEARCHED

Class	Subclass	Date	Examiner
710	53	2/9/2006	ASC
↓	54	↓	↓
	55		
	56		
	57		
709	200	↓	↓
↓	213		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT	2/9/2006	ASC